

Search Notes**Application/Control No.**

10/692,800

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
712	244	7/21/2008	BPG
717	129	7/21/2008	BPG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search	7/21/2008	BPG
Updated NPL search (IEEE Xplore and Google Scholar)	7/21/2008	BPG
Inventor name search	7/21/2008	BPG